

Search Notes

Application/Control No.

10/808,807

Applicant(s)/Patent under
Reexamination

CHENG ET AL.

Examiner

Art Unit

Kagnew H. Gebreyesus

1652

SEARCHED

Class	Subclass	Date	Examiner
435	67	12/15/2004	KG
	252.3	12/15/2004	KG
	254.2	12/15/2004	KG
	254.11	12/15/2004	KG
	257.2	3/4/2005	KG
	183	3/4/2005	KG
	254.21	3/4/2005	KG
	252.22	3/4/2005	KG
	254.6	3/4/2005	KG
	252.31	3/4/2005	KG
	254.23	3/4/2005	KG
	419	3/4/2005	KG
	252.2	3/4/2005	KG
	320.1	3/4/2005	KG

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
536	23.2	3/4/2005	KG
435	67	3/4/2005	KG
	252.3	3/4/2005	KG
STIC sequence search of SEQ ID NO: 18 and SEQ ID NO 2.		3/6/2005	KG

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC sequence search	3/6/2005	KG
EAST Key word search	12/15/2004	KG
EAST	3/4/2005	KG
PubMed	1/24/2005	KG
PubMed	3/4/2005	KG

Search Notes (continued)

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